

# Simulation of Gas Detectors Using Ramo's Theorem

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# Outline

- ✦ Ramo's Theorem
- ✦ Application: ILC & LHC
- ✦ Overview of the sTGC
- ✦ Simulation & Analysis
- ✦ MC & Data

# Induced Charge and Ramo's Theorem



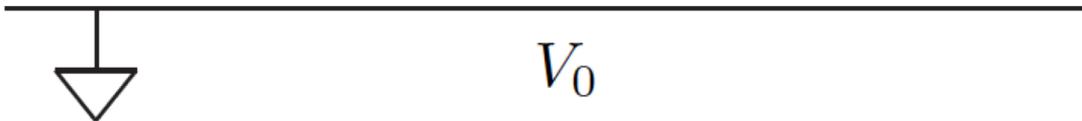

$$Q_1 = ?$$

- Ramo's theorem provides an intuitive method for determining the induced charge,  $Q_1$ , on a grounded electrode
- We can set the potential of the electrode to  $V_0$  creating a "weighted potential,"  $\psi(x)$ , in the area around the electrode
- The induced charge becomes the ratio of the weighted potential over  $V_0$  multiplied by the charge

# Induced Charge and Ramo's Theorem



$\psi_1(x)$  



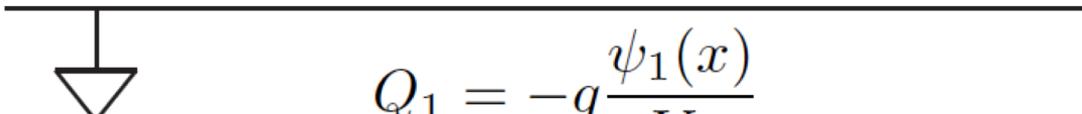
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# Induced Charge and Ramo's Theorem



$$\psi_1(x) \bullet q$$

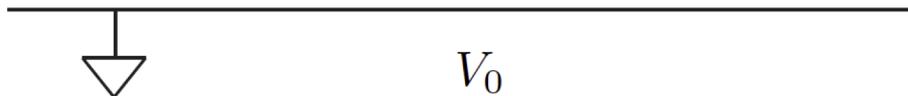
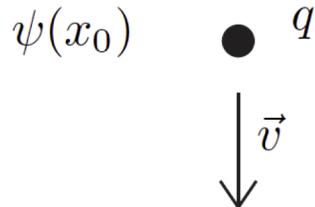
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$$Q_1 = -q \frac{\psi_1(x)}{V_0}$$

# Ramo's Theorem and a Moving Charge



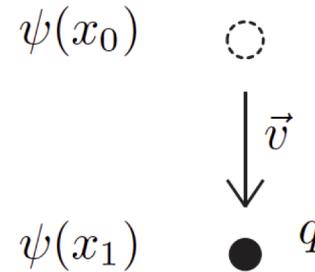
- When considering a moving charge we can treat it in the same way
- The amount of charge that flows from the electrode to ground is given by the change in the weighted potential moving from  $x_0$  to  $x_1$





# Ramo's Theorem and a Moving Charge

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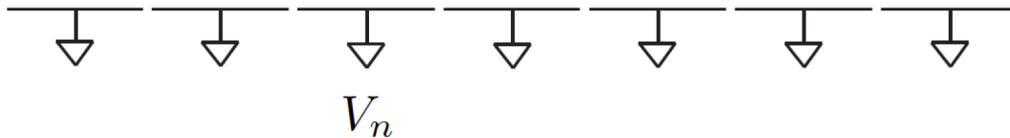
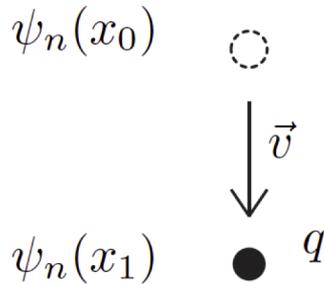
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$$Q = \frac{q}{V_0} [\psi(x_1) - \psi(x_0)]$$



# Charge Induction on Segmented Electrodes

$$V_n = V_0 \quad Q_n = \frac{q}{V_0} [\psi_n(x_1) - \psi_n(x_0)]$$



- When a charge moves towards a system of segmented electrodes, we can repeat the same process
- Set potential of one electrode to  $V_0$  and the rest to zero
- Difference in weighted potential for that electrode is proportional to the charge that flows through that electrode
- This is repeated for all electrodes

# Application



## International Linear Collider (ILC)

MicroMegas

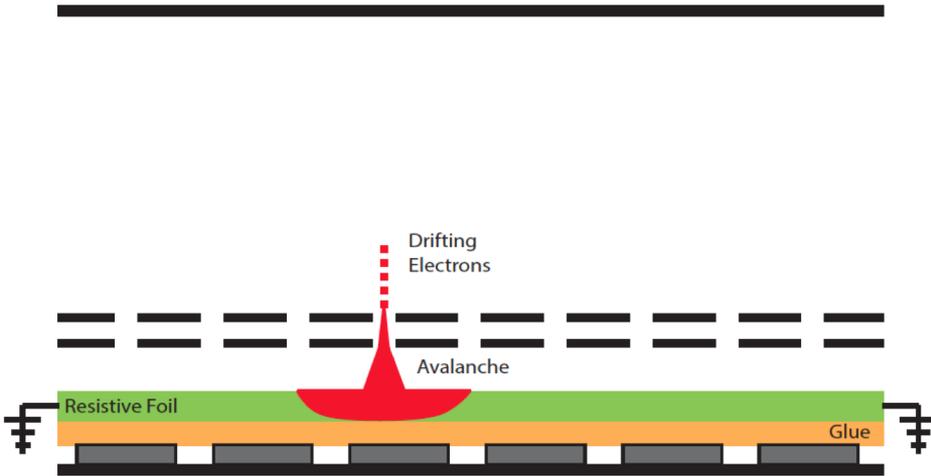


Image obtained from M.S. Dixit and A. Rankin "Simulating the Charge Dispersion Phenomena in Micro Pattern Gas Detectors with a Resistive Anode," [arXiv:physics/0605121](https://arxiv.org/abs/physics/0605121) [physics.ins-det] May 2006

- Used in developing the model to explain charge dispersion on a resistive coating

## Large Hadron Collider (LHC)

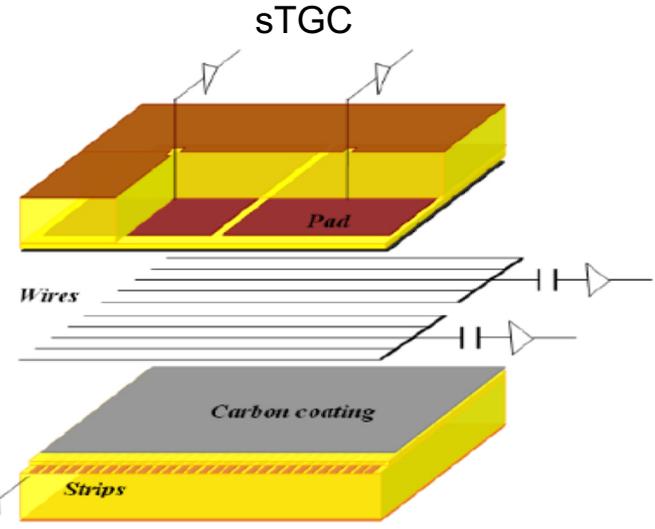
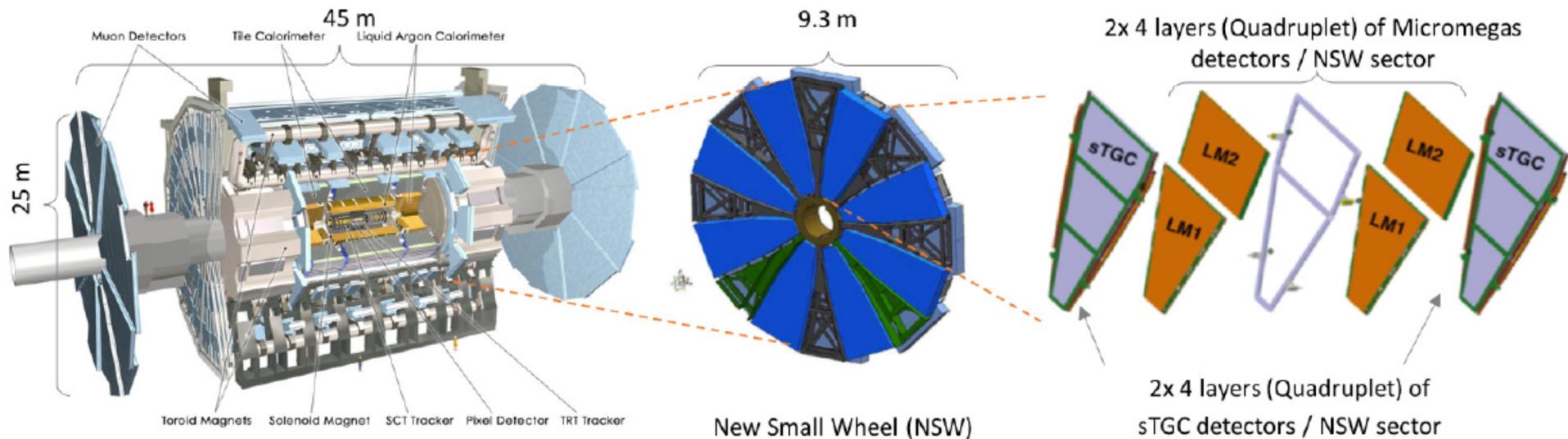


Image obtained from I. Roth, A. Klier and E. Duchovni "Testing sTGC with small angle wire edges for the ATLAS New Small Wheel Muon Detector Upgrade," [arXiv:1506.01277v1](https://arxiv.org/abs/1506.01277v1) [physics.ins-det] June 2015

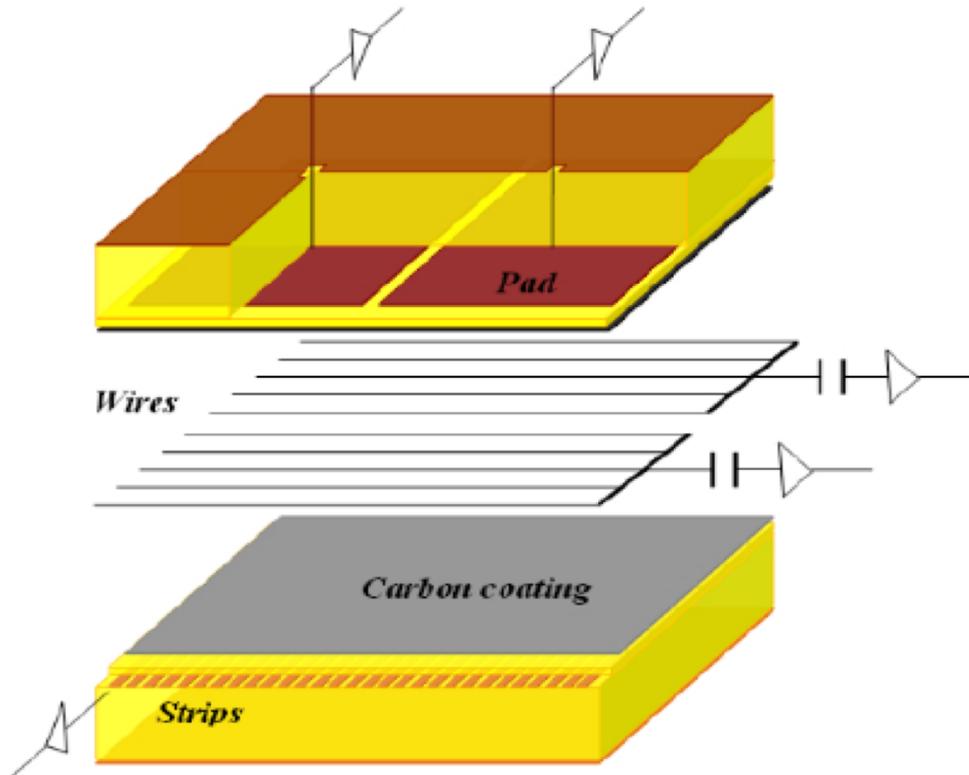
- Use data collected at test beam to further develop the simulation for application at LHC

# What is the sTGC?

- Small strip Thin Gap Chamber
- Part of upcoming New Small Wheel (NSW) upgrade
- Provides muon tracking in the end-cap region of ATLAS



# How It Works

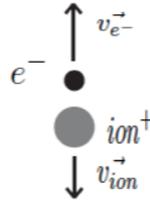


- Multiwire proportional chamber
- Comprised of gold plated tungsten wires in between two cathode planes
- Wires held at  $\sim 3\text{kV}$  with a pitch of  $1.8\text{mm}$
- Strips are perpendicular to wires along cathode plane with  $3.2\text{mm}$  pitch
- Pads cover opposite plane
- Volume filled with 45:55 mixture of n-pentane: $\text{CO}_2$
- Resistive carbon coating covers cathodes

# How It Works



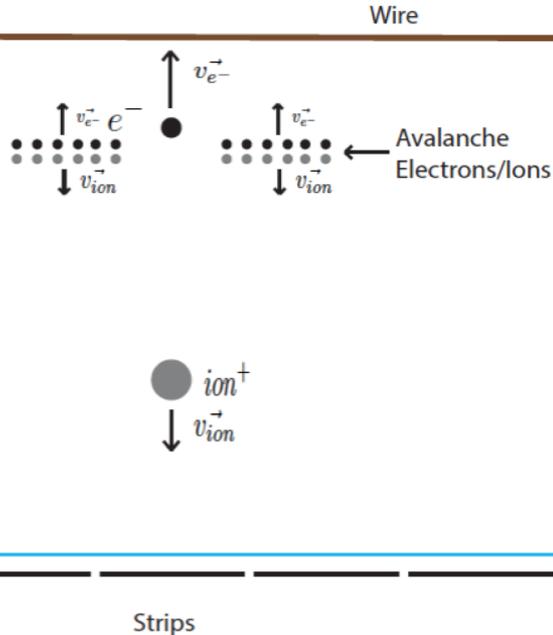
Wire



Strips

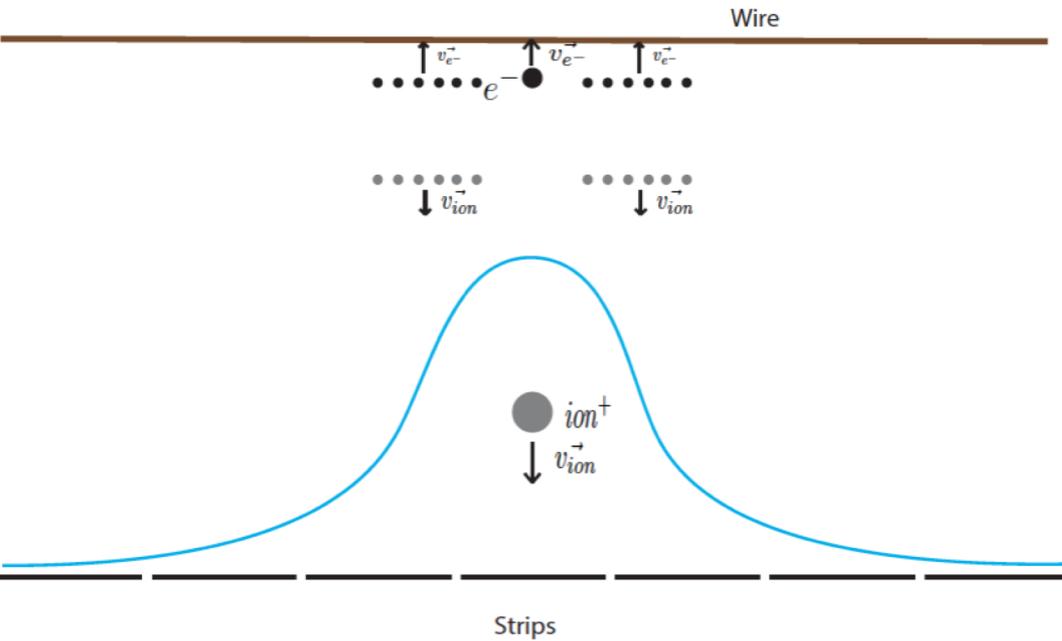
- Muon traverses chamber ionizing gas
- Electrons drift towards wires, ions drift towards cathode
- Drifting electron gains energy near wire producing an electron avalanche
- Avalanche causes an induction of charge on the surface of the strips
- Amount of charge induced on the strips follows a Gaussian distribution

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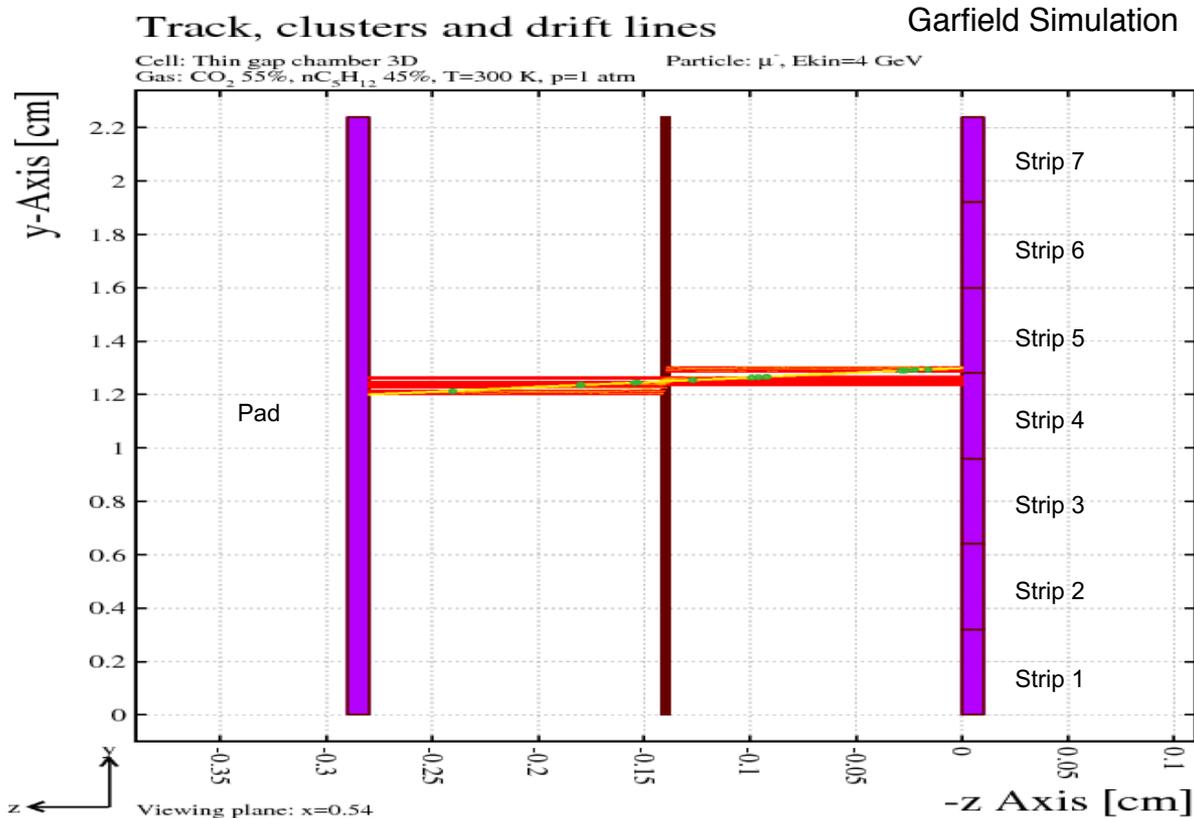
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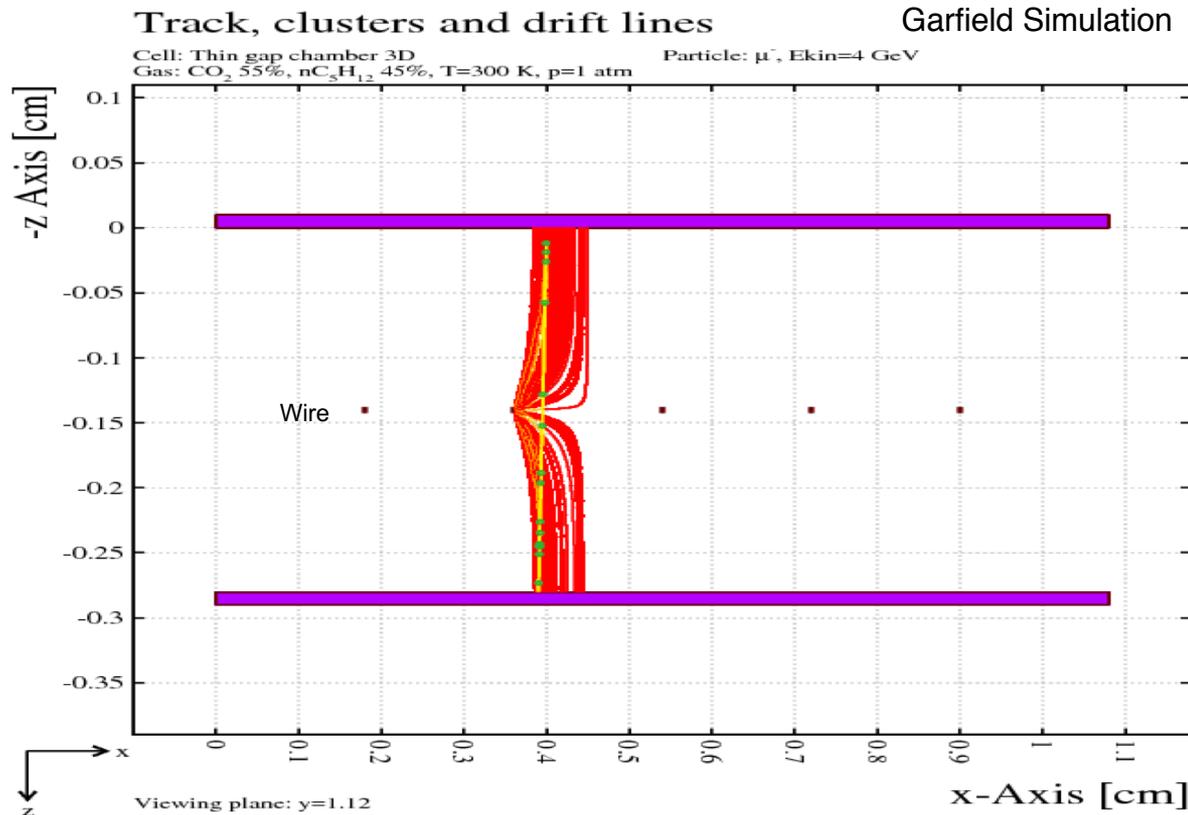
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# Simulation of the sTGC



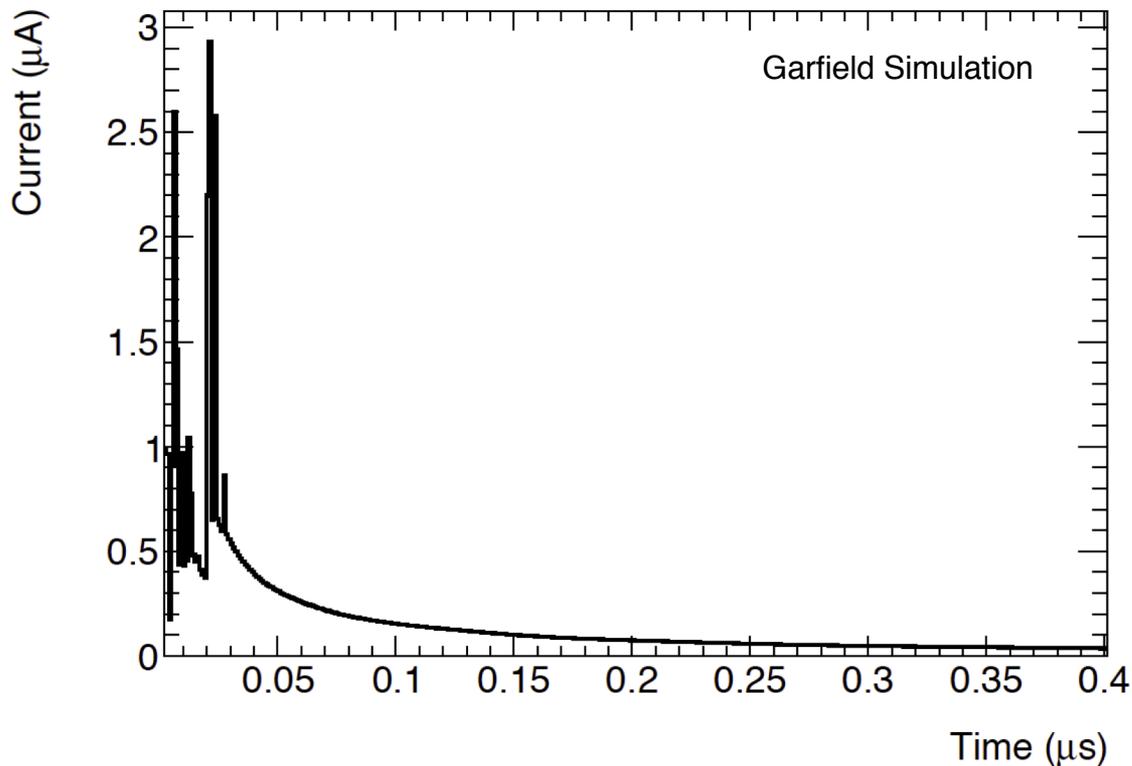
- Conducted using Garfield gas detector simulation software
  - Small slice of detector made up of 5 wires, 7 strips, and 1 pad
  - Single muon track passes through with an energy of 4 GeV at random angles,  $8^\circ < \theta < 30^\circ$  above z axis in yz-plane  
 $0^\circ < \phi < 22^\circ$  from z axis in xz-plane
- Legend:
- Track
  - electron
  - ion
  - ionization location

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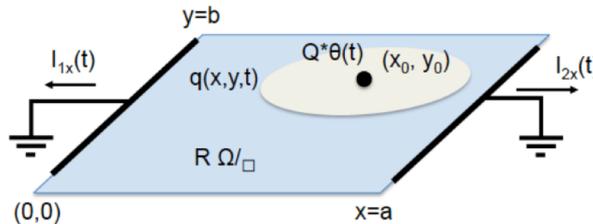
# Simulation of the sTGC



- Simulation only outputs raw signal
- Need to account for:
  - Resistive layer (for strips)
  - Readout electronics (for wires and strips)

# Resistive Layer

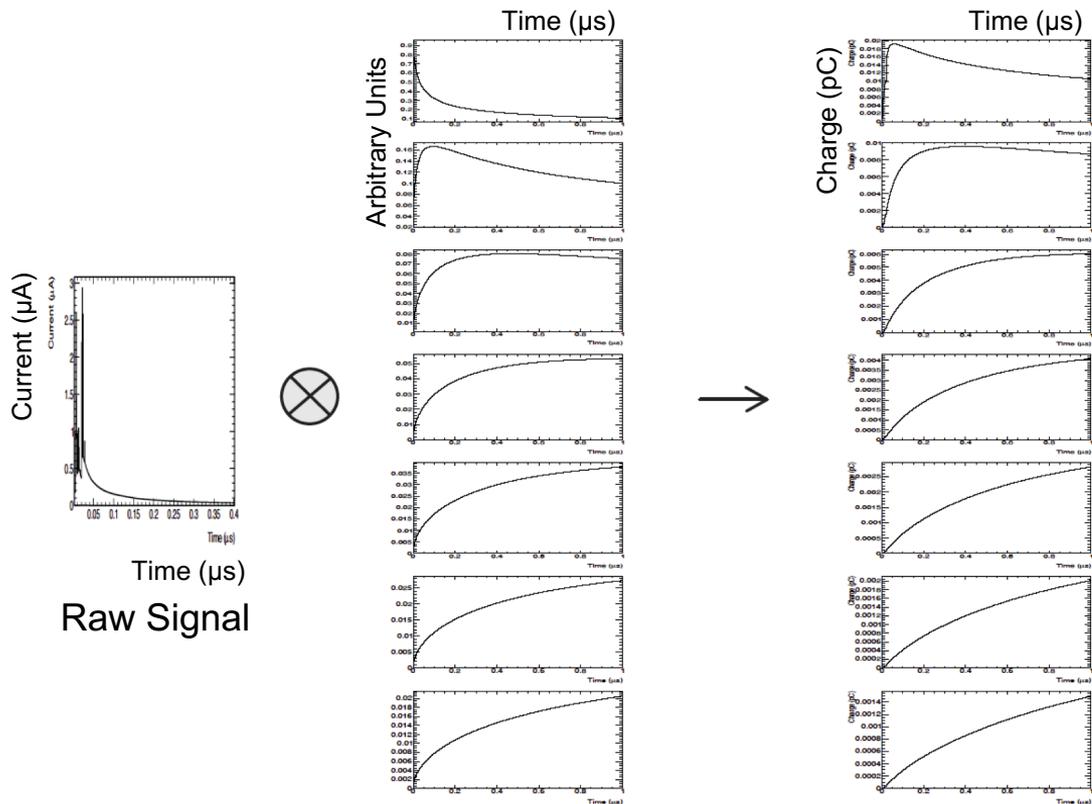
- Purpose:
  - Improve spatial resolution
  - Protect electronics against discharge
  - Mitigate charge deposition at high rate
- Resistive coating is sprayed on prepreg layer covering cathode
- Creates capacitive coupling between layer and strips/pad
- RC time constant controls spread of charge distribution
- Response function of layer is proportional to time constant



$$R(t) = \tan^{-1}\left(\frac{x_{high}}{\sqrt{4ht}}\right) - \tan^{-1}\left(\frac{x_{low}}{\sqrt{4ht}}\right)$$

$$h = \frac{1}{RC}$$

# Resistive Layer

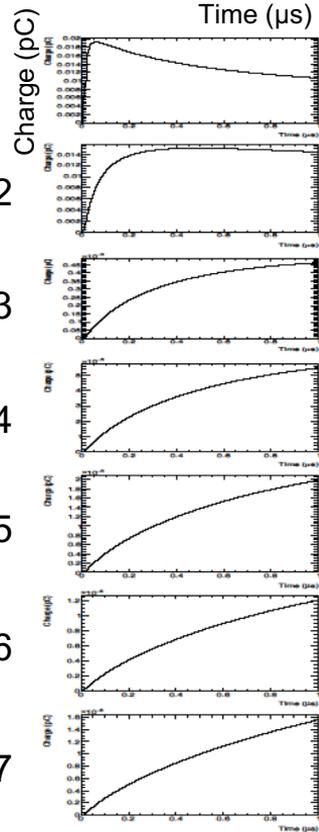


- Charge is not “stuck” to one strip, it flows across resistive layer
- Convolute signal with response function corresponding to the strip the charge flows to
- Total charge on strip is determined by summing the contributions of charge that flows from each strip



# Resistive Layer

Q(t) Strip 1



Charge from Strip 2

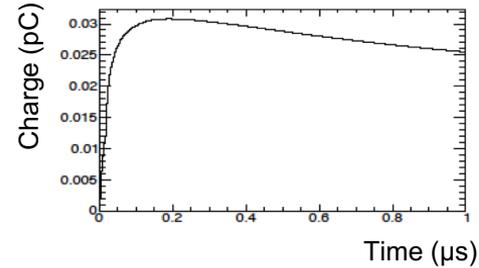
Charge from Strip 3

Charge from Strip 4

Charge from Strip 5

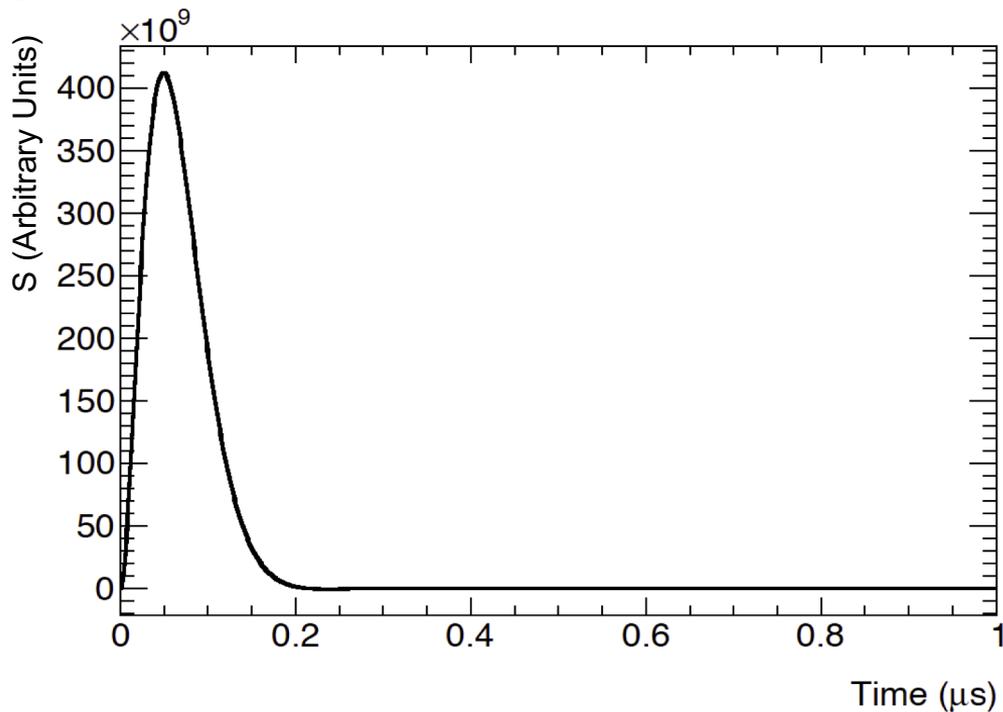
Charge from Strip 6

Charge from Strip 7



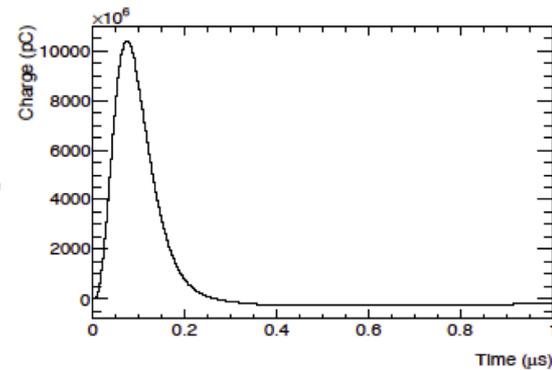
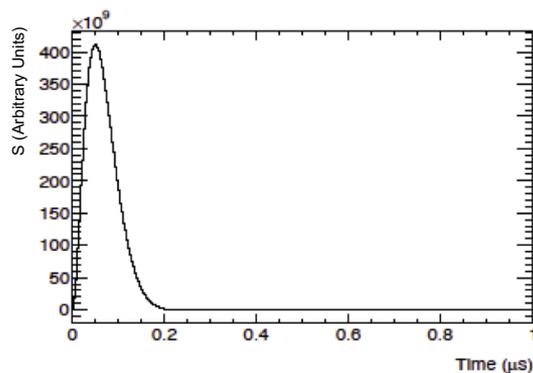
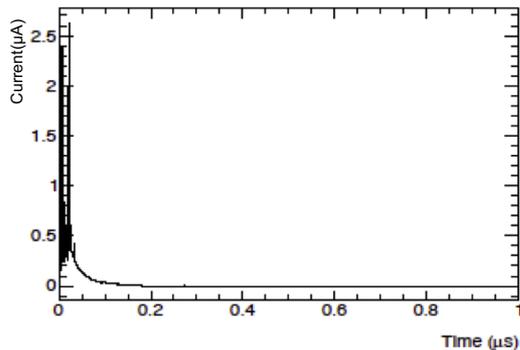
Total Summed Charge

# Readout Electronics



- Strip and wire readouts are connected to an ASIC chip, known as the VMM
- VMM monitors the current and enables the readout circuit once above a certain threshold
- Final output signal is obtained from convolution with VMM shaping function,  $S(t)$ , with a peaking time of 50 ns

# Convolution with VMM

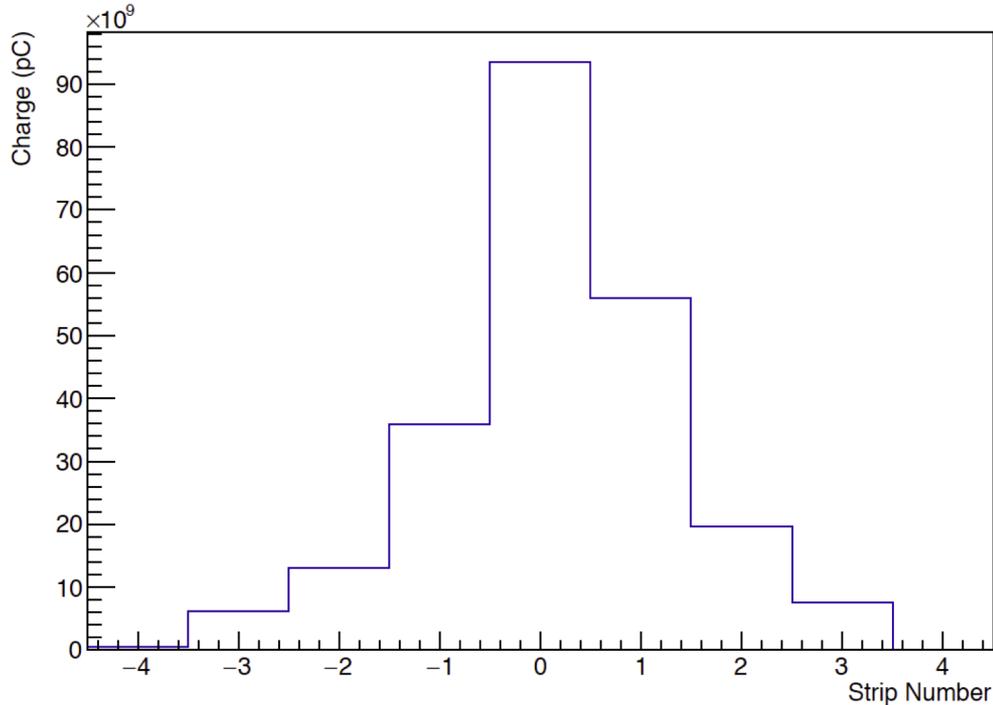


Derivative of Summed Charge

Shaping Function

Final Output Signal

# Charge Distribution of Strips

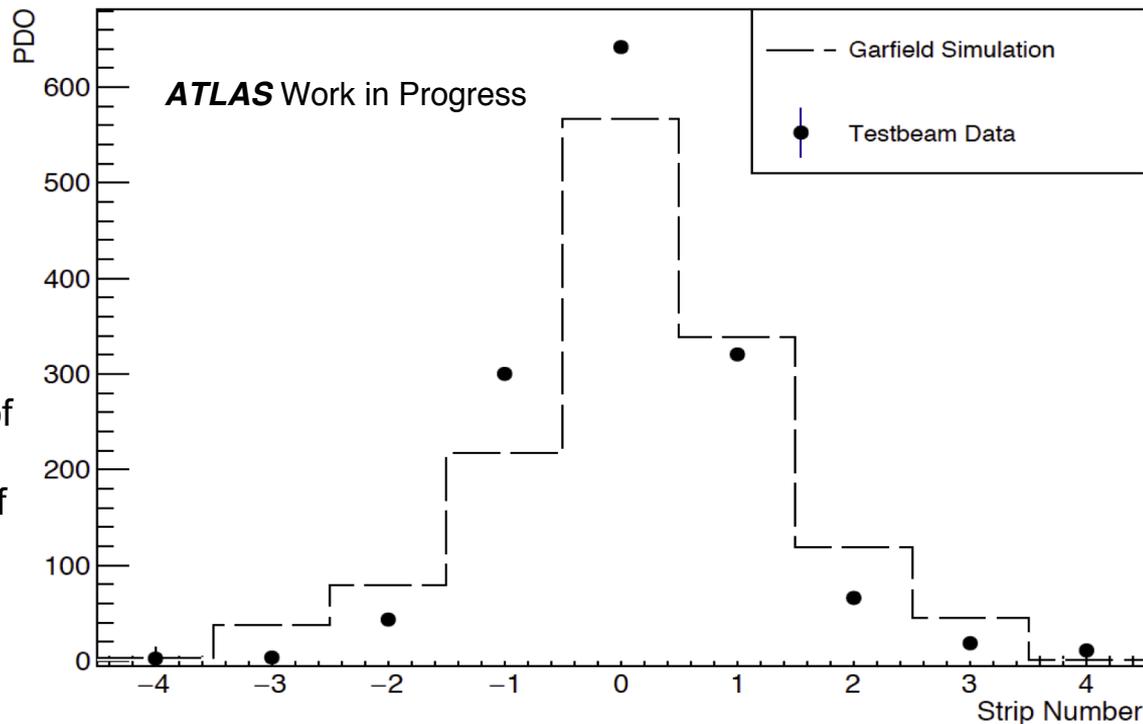


- Strip with max charge is centre strip
- Plot peak values to determine charge distribution
- Values are averaged over multiple simulations

# Comparison with Test Beam



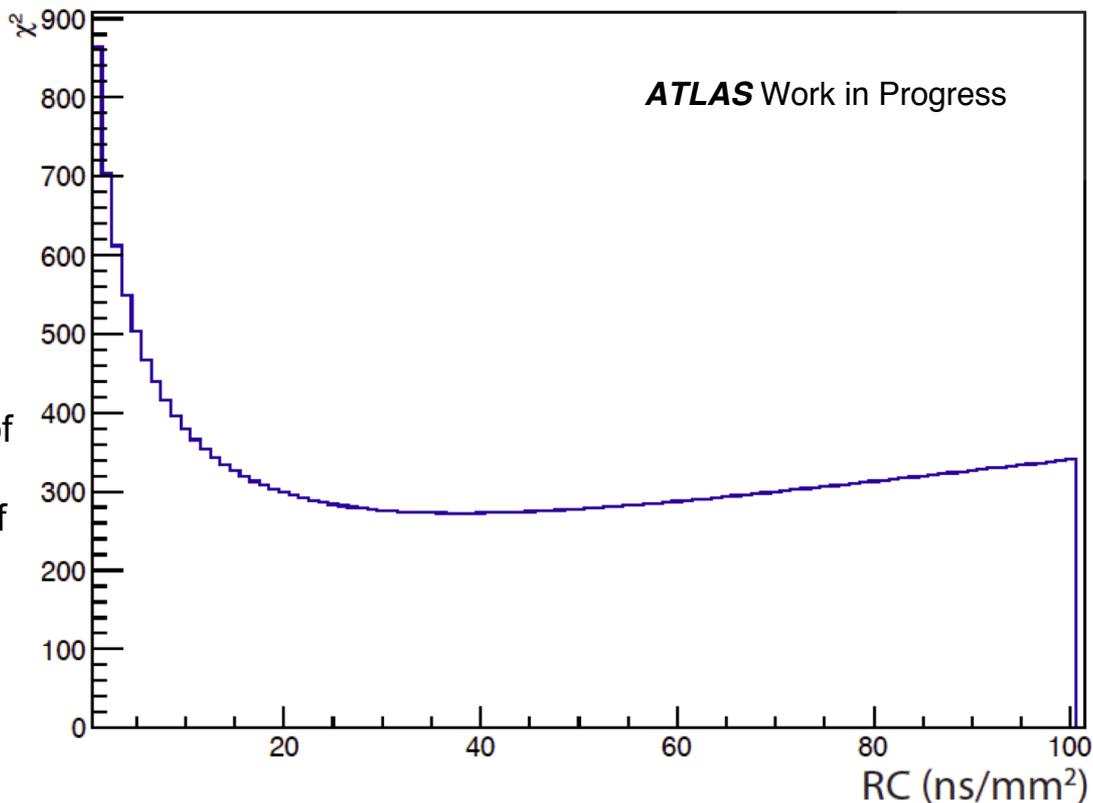
- Test beam measures Peak Detector Output (PDO) using 10-bit ADC
- Monte Carlo is scaled to PDO
- Goodness of fit corresponds to an **RC value of 38 ns/mm<sup>2</sup>**
- This corresponds to a resistance of 190 k $\Omega$  for the resistive layer with prepreg/resistive layer thickness of 200  $\mu$ m
- **Agrees well with construction parameters of tested sTGC with RC of 40 ns/mm<sup>2</sup> and resistance of 200 k $\Omega$  at 200  $\mu$ m**



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# Time of Arrival of Electron Clusters



Results from ATLAS NSW Technical Design Report

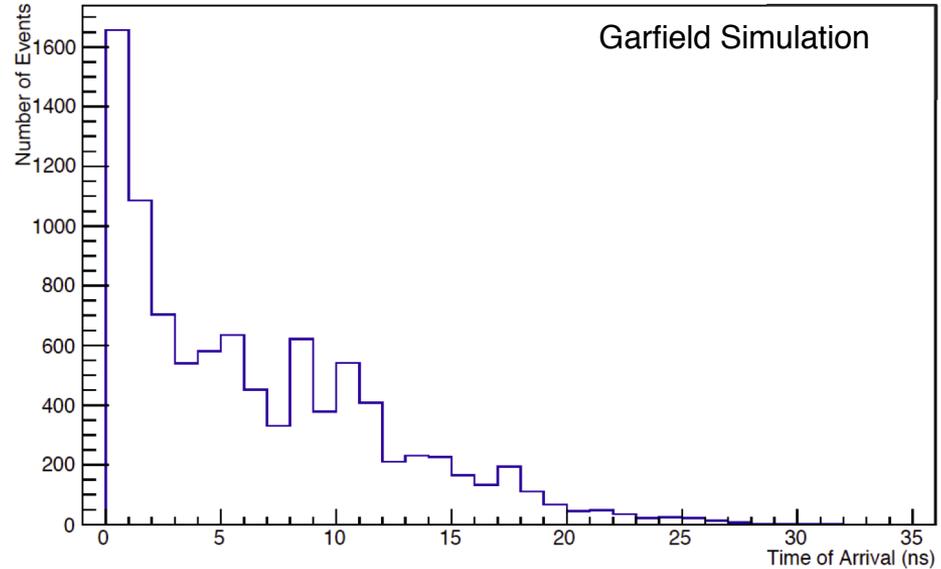
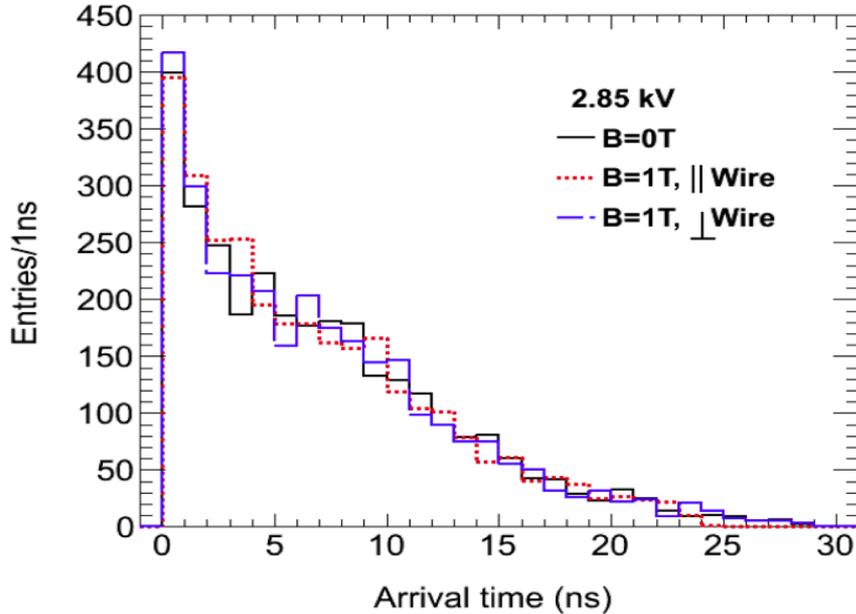


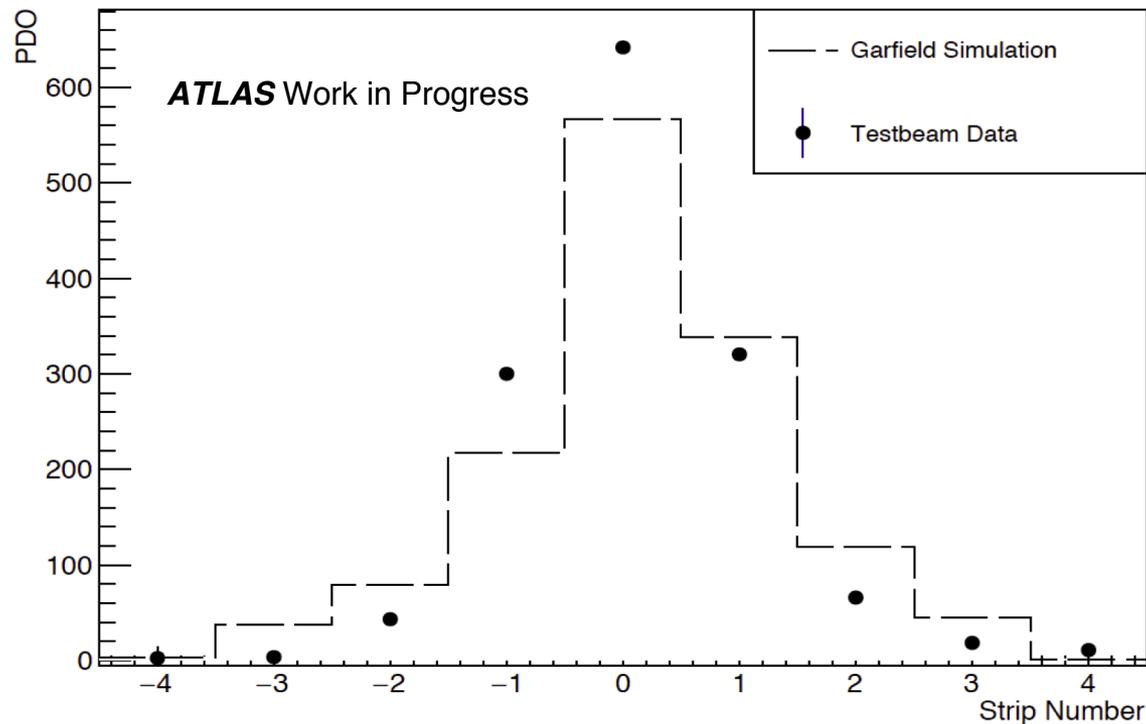
Image obtained from ATLAS Collaboration "ATLAS New Small Wheel Technical Design Report," CERN-LHCC-2013-006 ATLAS-TDR-20-2013

Arrival time of clusters to the wire is in accordance with known results

# Conclusion

- Ramo's theorem can be used to determine charge induced on surfaces
- Study of signal generated on anodes (wires) and cathodes (pads & strips) of ATLAS sTGC
- By considering the factors that contribute to the final signal formation, our simulations effectively characterize the behaviour of the sTGC

Comparison of Testbeam Data and Monte Carlo





Thank You!